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			U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NOX114-00009		SERIAL NO. Not yet assigned	
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PHORMATION DISCLOSURE			Atty. Docket No.: 6173/4019US			Application No.: 09/937,949	
M 2 2	2 2001 (8)	H -	Applicants: Benoist Sebire et al.				
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Sheet 1 of 1

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Examiner: Binh Quoc Nguyen AbwA	Date Considered:	08/3/05